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UNITED STATES PATENT AND TRADEMARK OFFICE CERTIFICATE OF CORRECTION

PATENT NO. : 6,762,826 B2 DATED : July 13, 2004

INVENTOR(S) : Izumi Tsukamoto et al.

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It is certified that error appears in the above-identified patent and that said Letters Patent is hereby corrected as shown below:

Title page,

Item [57], ABSTRACT, delete the current abstract and insert the following therefor:
-- An apparatus for holding a substrate includes a table, protrusions, being provided on the table, on which the substrate is to be supported, and at least a portion of an attracting unit, the attracting unit attracting the substrate onto the protrusions. The apparatus is arranged such that the protrusions are disposed in accordance with a pattern formed on or to be formed on the substrate. --

Column 1,

Line 15, "in" should read -- in the --.

Line 27, "made" should read -- made to --.

Line 35, "Where" should read -- When --.

Line 50, "such" should read -- such a --

Line 60, "are" should be deleted.

Line 61, "communicated" should read -- communicate --.

Line 66, "wafer" should read -- wafer, -- and "substrate" should read -- substrate, --.

Column 2,

Line 27, "marks" should read -- mark --.

Line 28, "protrusions" should read -- a protrusion --.

Line 47, "can" should read -- can- --.

Line 64, "made" should read -- made to be --.

Column 3,

Line 1, "portion" should read -- portion, --.

Lines 6 and 7, "as" should read -- is --.

Line 8, "solving" should read -- solve --.

Line 36, "where" should read -- when --.

Line 38, "pitch" should read -- pitch of --.

Line 43, "focus" should read -- focus of --.

Line 44, "precision" should read -- precision of --.

Column 4,

Line 3, "in" should read -- with --.

Line 15, "error" should read -- error, -- and "coordinate" should read -- the coordinates --.

Line 18, "substrate." should read -- substrate, is reduced. --.

Line 22, "provided on said holding table, said protrusion" should be deleted.

Line 33, the second occurrence of "a" should be deleted.

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CERTIFICATE OF CORRECTION

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It is certified that error appears in the above-identified patent and that said Letters Patent is hereby corrected as shown below:

Column 5,

Line 64, the first occurrence of "curves" should be deleted and "double-ends" should read -- double-end --.

Column 7,

Line 1, "100" should read -- 100, --.

Line 9, "1C)" should read -- 1C), --.

Lines 10 and 12, "to" should read -- to the --.

Line 11, "13" should read -- 13, --.

Lines 16 and 18, "2" should be deleted.

Line 33, "and" should read -- and a --.

Column 8,

Line 2, "coordinate" should read -- coordinates --.

Line 24, "marks" should read -- mark --.

Line 25, "kept" should read -- maintained --.

Line 29, the first occurrence of "the" should be deleted.

Lines 46, 53 and 64, "to" should read -- to the --.

Lines 50 and 57, both occurrences of "in" should read -- in the --.

Lines 59, 60 and 63, "in" should read -- in the --.

Column 9,

Line 54, "is" should read -- are --.

Column 10,

Line 12, "advantageously" should read -- advantageously, --.

Line 30, "as" should read -- as those --.

Column 11,

Line 17, "such" should read -- such a --.

Line 18, "is" should read -- are --.

Line 34, "such" should read -- such a --.

Line 45, "relatively" should read -- relative --.

Line 61, "In" should read -- On --.

Column 12,

Line 50, "such" should read -- such a --.

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Column 13,

Line 26, "such" should read -- such a --;

Line 48, "can not" should read -- cannot --.

Column 14,

Line 5, ""reticle")" should read -- "reticle"), --.

Line 24, "material" should read -- material, --.

Line 35, "can not" should read -- cannot --.

Line 42, "in" should read -- with --.

Lines 53 and 60, "even" should read -- evenly --.

Line 56, "Where" should read -- When --.

Line 61, "to" should read -- to the --.

Column 15,

Line 17, "in" should read -- in the -- and "x" should be deleted.

Line 18, "location" should read -- location, --.

Line 19, "in" should read -- in the --.

Column 16,

Line 35, "an" should read -- a --.

Column 17,

Line 5, "60-deg." should read -- 60-degree --.

Line 7, "on" should read -- on a --.

Line 47, "even" should read -- evenly --.

Line 57, "Where" should read -- When --.

Column 18,

Line 5, "where" should read -- when --.

Line 6, "follow" should read -- follows --.

Line 15, "Where" should read -- When --.

Line 25, "Since" should read -- Since, -- and "practice" should read -- practice, --.

Lines 31, 32 and 36, "in" should read -- in the --.

Line 51, the second occurrence of "surface," should read -- surface, or --.

Column 19,

Line 3, "relatively" should read -- relative --.

Line 7, "in" should read -- with --.

Line 9, "practically" should read -- practically, --.

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It is certified that error appears in the above-identified patent and that said Letters Patent is hereby corrected as shown below:

Column 9 (cont'd),

Lines 12, 40, 56 and 60, "60-deg." should read -- 60-degree --.

Line 15, "where" should read -- when --.

Line 29, "of" should read -- in --.

Line 33, " $(=2^{1/2})$ " should read -- $(=2^{1/2})^4$) --.

Line 34, "2)4)" should be deleted.

Line 35, "Since" should read -- Since, -- and "however" should read -- however, --.

Line 63, "poi" should read -- point --.

Column 20,

Line 41, "of" should read -- having -- and "diameter" should read -- diameter of --.

Column 21,

Line 19, "can not" should read -- cannot --.

Line 30, "of" should read -- having -- and "diameter" should read -- diameter of --.

Line 32, "in" should read -- on --.

Line 40, "in" should read -- in the --.

Line 41, "be come" should read -- become --.

Line 54, "strict" should read -- stricter --.

Column 22,

Line 19, "h=0.725" should read -- h=0.625 --.

Line 35, the second occurrence of "in" should read -- with --.

Column 23,

Lines 27 and 39, "60-deg." should read -- 60-degree --.

Line 30, " $n(\frac{2}{3})^{1/2}$)/L²" should read -- $n=(\frac{2}{3})^{1/2}$ /L² --.

Line 32, "where" should read -- when --.

Line 63, "with" should be deleted.

Line 64, "it" should be deleted; "is" should read -- is, -- and "principle" should read -- principle, --.

Column 24,

Line 9, "in" should read -- in the --.

Line 31, "thereof," should read -- thereof, a --.

Line 32, "on" should read -- of --.

Line 34, "potion" should read -- portion --.

Line 49, "a even" should read -- an evenly --.

Line 55, "Where" should read -- When --.

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It is certified that error appears in the above-identified patent and that said Letters Patent is hereby corrected as shown below:

Column 25,

Line 7, "give" should read -- given --.

Line 10, "where" should read -- when --.

Line 32, " $P \le [(15.38 \cdot E \cdot h^3 \cdot dz)/c_1] \cdot (1/L^4)$ " should read -- $P \le [(15.38 \cdot E \cdot h^3 \cdot dz)/c_1] \cdot (1/L^4)$ --.

Line 59, "tolerance dz is 80 nm and the wafer distortion" should be deleted.

Line 61, the first occurrence of "is" should read -- as --.

Line 67, "L" should read -- L, --.

Column 26,

Line 62, "in" should read -- with --.

Column 27,

Line 39, "in" should read -- with --.

Line 50, "Where" should read -- When --.

Column 28,

Line 1, "Where" should read -- When --.

Line 9, "In" should read -- On --.

Lines 14, 15, 16 and 21, "pin" should read -- pins --.

Line 48, "may" should read -- may be --.

Line 49, "made narrow properly." should read -- made properly narrow. --

Line 57, "V." should read -- v. --.

Line 61, "with" should read -- with the --.

Column 29,

Line 5, "345" should read -- 385 --.

Line 27, "In" should read -- On --.

Line 30, "imaging" should read -- image -- and the second occurrence of "or" should be deleted.

Line 39, "pressers" should read -- pressure --.

Line 45, "a" should be deleted.

Line 49, the first occurrencee of "382" should read -- 381 --.

Column 30,

Line 4, "Where" should read -- When --.

Line 7, "not" should read -- not to --.

Lines 15 and 30, "In" should read -- On --.

Line 21, the second occurrence of "In" should read -- On --.

Line 22, "Lx" should read -- Lx, --.

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DATED

: July 13, 2004

INVENTOR(S) : Izumi Tsukamoto et al.

It is certified that error appears in the above-identified patent and that said Letters Patent is hereby corrected as shown below:

Column 31,

Line 28, the first occurrence of "In" should read -- On --.

Line 39, "forgoing" should read -- foregoing --.

Line 45, the second occurrence of "is" should read -- be --.

Line 47, the first occurrence of "is" should read -- is set to be -- and "is satisfied," should be deleted.

Line 55, "In" should read -- On --.

Column 32,

Line 5, "In" should read -- On --.

Line 7, "has" should read -- have --.

Line 14, "for" should read -- for the --.

Line 15, "defect" should read -- defects -- and "device" should read -- devices --.

Line 23, "402" should read -- 402, --.

Column 33,

Line 3, "may" should read -- may, -- and "of course" should read -- of course, --.

Line 13, the first occurrence of "of" should read -- of a -- and "for" should read -- for the --.

Line 14, "e.g." should read -- e.g., --.

Line 28, "wherein" should read -- wherein an --.

Line 29, "check," should read -- check, a --.

Signed and Sealed this

Fifth Day of April, 2005

JON W. DUDAS
Director of the United States Patent and Trademark Office